

OCT 12 2004

Atty. Docket No.:
H0005820-0760
(1100.1222101)Serial No.:
10/749,863LIST OF PATENTS AND PUBLICATIONS FOR
APPLICANT'S INFORMATION
DISCLOSURE STATEMENT

Applicant: Ulrich Bonne et al.

Filing Date:
December 31, 2003Group Art:
unknown

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Examiner Initial	Document No.	Date	Name	Class	Sub Class	Filing Date If Appropriate
/C.T.M./	906,468	12/1908	Steynis			
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EXAMINER:	/Christine T Mui/ DATE CONSIDERED: 04/02/2008
EXAMINER:	Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.